XPS and ESR of SnSe_{2} **-1** $\%$ **P{CoCp₂}_{0.36}**

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We have measured the Co $2p_{3/2}$ X-ray photoelectron (XPS) spectrum of $SnSe_2-1%P(CoCp_{20.36}$ as a function of time and have found that the Co $2p_{3/2}$ profile changes with time. This indicates that SnSe₂-1% P{CoCp_{20.36} undergoes radiation damage as a result of X-ray exposure. Consideration of this damage is important when attempting to use XPS as a measure of the $Co²⁺/Co³⁺$ ratio is this material. Our X-band ESR spectra of SnSe₂-1%P{CoCp₂}_{0.36} are consistent with the presence of neutral cobaltocene in this material. Quantitative agreement between the *XPS* and **ESR** resulta is achieved when **the** temporal change in the XPS line shape is modeled using second-order kinetics.

Introduction

Superconductivity is **known** to occur in several of the layered transition-metal dichalcogenides, MX_2 , where M is an early transition metal and X is S, Se, or Te.' **An** important discovery in this field came in 1970 when Gamble et al. reported the dramatic increase in T_c of TaS_2 when the TaS_2 was intercalated with pyridine to produce TaS₂(pyridine) $_{1/2}$.² The T_c of pure TaS₂ is 0.7 K, whereas the pyridine intercalated material **has** a *T,* of **3.5** K. The inclusion of **an** organic molecule, pyridine, into an inorganic host, TaS_2 , raised the critical temperature by a factor of **5.** Recently, Formstone et **al.** have reported superconductivity in $SnSe_2-1%P$ when it is intercalated with coductivity in SnSe₂-1%P when it is intercalated with co-
baltocene (CoCp₂ where $Cp \equiv C_5H_5$) to produce S~-l%P(CoCp,J0~3 This **is** a remarkable *finding* given that neither SnSe_2 nor SnSe_2 -1% P have been shown to be intrinsic superconductors. In fact, $SnSe₂$, a layered post-transition-metal dichalcogenide, is a rather wide (1 eV) indirect bandgap semiconductor.⁴ The phosphorus is added to pure SnSe₂ to enhance its low electrical conductivity. Both the pure and phosphorus doped $SnSe₂$ are n-type semiconductors.³

In addition to ita intercalation chemistry with transitionand post-transtion-metal dichalcogenides, cobaltocene undergoes intercalation reactions into transition-metal phosphorus chalcogenides, $M_2P_2X_6$, where M is a transition metal and X is sulfur or selenium.⁵⁻¹⁰ An intriguing question regarding cobaltocene intercalation chemistry is what percentage of the intercalated cobaltocene molecules are oxidized upon intercalation. In the *case* of cobaltocene intercalation of TaS_2 , the evidence (primarily magnetic susceptibility) strongly suggesta that **all** of the intercalated cobaltocene molecules are oxidized to cobaltocenium,

 $CoCp_2^+$.¹¹ In contrast, our recent work using $Cd_2P_2S_6$ as the host lattice demonstrated that a significant $(\approx 20\%)$ amount of the intercalated cobaltocene can remain unoxidized, that is, neutral. Such a compound *can* be expressed **as**

$$
{\bf Cd_2P_2S_6} [CoCp_2]_{0.17} [CoCp_2^+]_{0.63}
$$

where the reduced **species** must be some component of the $Cd_2P_2S_6$ lattice. In the $Cd_2P_2S_6$ study, the relative amounts of cobaltocene and cobaltocenium were determined using a combination of chemical **analysis** and quantitative **ESR.** (The cobaltocene is paramagnetic and the cobaltocenium is diamagnetic.) A mixture of neutral and oxidized cobaltocene was also proposed by Parkinson et al.¹² for the intercalation compound formed between cobaltocene and SnS_2 . The resulting compound is written

$$
(\mathbf{Sn^{4+}}_{0.9}\mathbf{Sn^{2+}}_{0.1})\mathbf{S}_2[\mathbf{CoCp}_2]_{0.1}[\mathbf{CoCp}_2^+\mathbf{I}_{0.2}
$$

In this case, ¹¹⁹Sn Mössbauer spectroscopy was used to determine the specific component of the SnS_2 which served as the oxidizing agent. A combination of ¹¹⁹Sn Mössbauer, magnetic susceptibility, and X-ray photoelectron spectroscopy (XPS) was used to determine the relative amounts of cobaltocene and cobaltocenium in SnS₂. Their rationale for the mixture of $CoCp_2$ and $CoCp_2$ ⁺ is that the rationale for the mixture of $CoCp_2$ and $CoCp_2$ ⁺ is that the
redox potential of cobaltocene is close to the Fermi level
of SnS₂. As SnS₂ is reduced by cobaltocene (Sn⁺⁴ \rightarrow Sn⁺²),
the Fermi level of the interc of SnS₂. As SnS₂ is reduced by cobaltocene $(Sn^{+4} \rightarrow Sn^{+2})$, the Fermi level of the intercalated phase rises until it **equals** the redox potential of cobaltocene. At that point, there is no net driving force for further charge transfer, and subsequent intercalation involves only neutral cobaltocene molecules until steric effects prevent continued uptake. The net effect is the establishment of an equilibrium between oxidized cobaltocene and reduced $SnS₂$.

The important difference between TaS_2 , where the cobaltocene is fully cationic, and SnS_2 , where only some of the cobaltocene molecules are cationic, is the electron affinity, χ , of the host dichalcogenide. Ultraviolet photoelectron (UPS) measurements on TaS_2 and SnS_2 show that the electron affinity of TaS_2 is approximately 1 eV greater than that of SnS_2 .^{13,14} This is consistent with a

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higher degree of charge transfer between cobaltocene and $TaS₂$ versus cobaltocene and $SnS₂$. In determining the degree of charge transfer between cobaltocene and $SnS₂$ versus SnSe₂, the electron affinity again must be considered. In this case, the measured difference is small; χ = 4.2 eV for SnS_2 and 4.35 eV for SnSe_2 .¹⁴ Nonetheless, from this consideration alone, one would expect a higher degree of charge transfer between cobaltocene and $SnSe₂$ than between cobaltocene and SnS₂. The XPS and ESR results presented in this paper **are** consistent with that prediction. For quantitative agreement between the two techniques, however, the XPS results must be extrapolated to zero X-ray exposure time **as** discussed below.

The significance of the work presented in this paper is that it provides experimental results consistent with the mechanism put forward by Parkinson et **al.** At the same time, it highlights a pitfall in the use of XPS with intercalated materials and suggests that further study of the effect of X-ray irradiation on intercalated materials is required before XPS can be used **as** a diagnostic tool in the characterization of these materials.

Experimental Section

Preparation. Materials. All of the **materiala** used were from commercial suppliers and used **as** received. Tin was in the form of **20** meah granular and was supplied by Mallinckrodt. Selenium powder, 60 mesh, was supplied by Johnson Mathey Inc. (USA). Red phosphorus powder, amorphous, 100 mesh, was purchased from **Alfa.** Reeublimed iodine cryatah (used **as** transporting agent) were from Johnson Mathey Chemicels Ltd. (England). Anhydrous acetonitrile was obtained from Aldrich Chemical Co. Cobaltocene crystals were from Strem Chemical Co.

Synthesis. SnSe_2 -1P% was prepared from the constituent elements *using* chemical vapor transport. Stoichiometric amounts of tin and selenium **(4** g **total)** were ground together lightly to ensure complete mixing. Phosphorus **(1** mol %; **0.0044 g)** was added and ground **as** well. The sample was transferred to a quartz reaction tube, iodine crystals (0.217 **g)** were added, and the tube was sealed off under vacuum. The tube was placed in a horizontal tube furnace, and a temperature gradient established such that the cool crystal growing zone was at 610 °C. The hot zone of the tube was \approx 640 °C. Within 1 day all of the material transports from the hot zone to the cool zone. The tube is opened, and the product crystals are recovered. Any iodine adhering to the crystals is sublimed off prior to opening the reaction tube. The intercalated phase was prepared by soaking several crystals of SnSe2-l%P in a 0.1 **M** acetonitrile solution of cobaltocene for 21 days at 60 "C. The sample is prepared in a drybox because of the air sensitivity of cobaltocene. The reaction is run in a sealed **Pyrex** tube. At the conclusion of the reaction, the tube is opened in the **drybox,** and the crystals are **rinsed** with acetonitrile. Both before and after intercalation, the crystals are black, opaque, and lustrous.

Characterization. Surface Analysis. X-ray photoelectron spectroscopy, *XPS,* spectra were collected on **a** Perkin-Elmer Physical Electronics **560** (large double-pass cylindrical mirror analyzer (CMA)) system using a nonmonochromatic Mg $K\alpha$ X-ray source. The binding energy scale waa calibrated by adjusting the $3p_{3/2}$ and $2p_{3/2}$ photolines for clean copper to appear at 75.13 \pm 0.02 and 932.67 **●** 0.02 eV, respectively. Survey data were collected with a 100-eV pass energy, and multiplex data were collected at 25-eV pass energy. A 4-kV *Ar* ion beam was used for sputtering some of the specimens. The nominal sputter rate used to determine sputter damage was \approx 36 Å/min, calibrated for SiO₂. The $SnSe_2-1% P{CoCp₂}_{0.36}$ specimens were prepared for analysis by opening fresh layers for **analysis** in the **main** vacuum system. This was accomplished by mounting a flat portion of the material on a specimen mount in the spectrometer. The outer surface of the specimen was then placed in contact with double sticky tape. When the tape was pulled from the surface, a fresh layer of

Binding Energy (eV)

Figure 1. Co $2p_{3/2}$ XPS photoline from SnSe₂-1% P{CoCp_{20.36}. Spectra are from X-ray exposure times of (A) 15 min, (B) 120 min, and (C) 300 min.

material was exposed. Because of the way the specimen was mounted, there may be some *chargins* that **has** not been correcied for in the data.

Electron Spin Resonance. X-band (9.2 GHz) ESR spectra were recorded on a Varian E-9 spectrometer interfaced to an IBM AT compatible for data collection and signal averaging. The magnetic field was calibrated using a Micro-Now NMR gaussmeter. The proton resonance from an aqueous solution of copper sulfate was used **as** a calibration **standard.** The field was calibrated to ± 0.01 G. The klystron frequency was measured with a Systron Donner 6420 microwave counter. The klystron frequency is stable to ± 10 kHz (0.00001 GHz). Variable temperature is accomplished using an Air Products Helitran with liquid helium **as** the coolant.

Ancillary Characterization. Dc magnetic susceptibility data were colleded on a **SQUID** magnetometer at **the** National **Institute** of Standards and Technology (NIST) at Boulder, CO. X-ray powder diffraction data was collected on a Siemens automatic powder diffractometer using Cu *Ka* radiation. FTIR **spectra** were run on a Perkin-Elmer 1700 spectrometer interfaced to a Spectra Tech IR PLAN **1** microscope. The detector is a mercury-cadmium-telluride (MCT) detector which is cooled with liquid nitrogen. It has a useful range of 7000-700 cm⁻¹. Mass spectroscopic data were obtained on a high-resolution VG 7070 **EHF** mass spectrometer.

Results

Preliminary Characterization. Dc magnetic susceptibility experiments confirmed that our samples were superconducting below 6 K **as** reported by Formstone et d.3 X-ray diffraction data, collecting only *(Ool)* lines, indicate that none of the SnSe₂-1% P remains unintercalated. The value of d(Oo1) of 11.43 **A** corresponds to an increase of 5.32 A, consistent with what **has** previously been observed for cobaltocene intercalation into other layered **materiels.63** SnSe2-1 % P transmits infrared radiation above **700** cm-', the lower limit of sensitivity of the MCT detector. Upon intercalation of cobaltocene to yield $SnSe_2-1\% P{CoCp_2}_{0.36}$ no infrared radiation is transmitted over the range **7000-700** cm-'. This is consistent with the reported high electrical conductivity of the intercalated phase? Mass spectroscopy of the volatile compounds upon heating under vacuum reveals a strong *mle* peak at 189, the parent molecular ion of cobaltocene. The conclusions from this preliminary characterization are that the sample is a superconductor below 6 K, is fully intercalated, is metallic at room temperature, and the cobaltocene remains intact upon intercalation.

Surface Analysis. The XPS spectrum of SnSe₂-1%P(CoCpz)o,3s recorded at several different times is **shown** in Figure 1. Several features are immediately apparent. First, the line is a composite one made up of at least two individual lines. Second, the overall shape of the line changes **as** a function of X-ray exposure time. The low-

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Figure 2. Ratio of Co^{2+}/Co^{3+} as a function of X-ray exposure time. Solid line is **a** first-order kinetics fit using eq 3; see text.

Figure 3. Co $2p_{3/2}$ XPS photoline from SnSe₂-1%P{CoCp₂}_{0.36} before (A) and after (B) a 5-s, 4-keV argon ion sputter. The effect of the ion sputter is **to** reduce the high binding energy component of the line shape.

energy line gains intensity **as** a function of time. This composite nature of the Co $2p_{3/2}$ line has been reported before.^{12,15} The assignment, which we adopt, is that the high-energy peak is from **Co3+** and the low-energy peak from **Co2+.** It is difficult to determine what the intensity of the **Co2+** line is at very short exposure times **because** of the low signal/noise associated with a single XPS scan. ESR experiments (see below) suggest that the concentration of **Co2+** is low, but not zero. A plot of the intensity of the **Co2+** peak with respect to the **Co3+** peak (filled circles) is shown in Figure 2.

The effect of a 4-keV **Ar+** sputter *(5* **a)** can be seen in Figure 3. The high-energy peak $(Co³⁺)$ is effected much more *80* than the low-energy **peak (Co2+).** In Figure 3, the spectrum shown before the sputtering is the result of several hours of X-ray irradiation. The **spectrum** displayed after sputtering has been exposed for less than 10 min. It is not clear at this time whether **Co3+** species are being sputtered off the surface or whether they are being reduced to **Co2+** (or lower).

The amount of cobaltocene intercalated into the $SnSe₂-1%P$ lattice was determined from the integrated XPS photolines from Sn and Co. The entire Co $2p_{3/2}$ profile (after **300** min of exposure time) was integrated, and therefore **all** of the cobalt present has been assigned to either cobaltocene **(Co2+)** or cobaltocenium **(Co3+).** No allowance was made for decomposition products containing cobalt.

Electron Spin **Resonance. ESR** spectra of SnSe₂-1%P{CoCp₂}_{0.36} for two orientations differing by 90° are shown in Figures **4** and *5.* The spectrum in Figure 4

Figure 4. X-band ESR spectrum of SnSe₂-1% P{CoCp_{20.36} at *5* K. Sample is oriented to maximize the hyperfine resolution. Spectrum is the sum of **49** scans, 1 min/scan.

Figure 5. X-band ESR spectrum of $SnSe_2-1%P{CoCp₂}_{0.36}$ at *5* K. Sample is rotated **90°** with respect to the spectrum shown in Figure **4.** Spectrum is the **sum** of **4** scans, 1 min/scan.

Table I. **ESR Spin Hamiltonian Parameters for** $SnSe₂-1%$ PiCoC_D, by

| $g_{zz} = 2.047$ | $A_{12} = 186 \text{ MHz}$ | |
|-------------------------|------------------------------|--|
| $g_{yy} = 1.9^a$ | $A_{yy} = 70 \text{ MHz}^a$ | |
| $g_{xx} = 1.8^a$ | $A_{xx} = 100 \text{ MHz}^a$ | |
| ^o Estimated. | | |

is the result of **signal** averaging **49** scans, and the spectrum

in Figure **5** was the result of **4** scans. The sweep time was 1 min/scan, the modulation amplitude was 10 G peak**to-peak,** the microwave power was 2 mW, and the klystron frequency was 9.21324 ± 0.00001 GHz. The spectra were analyzed using a spin Hamiltonian appropriate for $S = \frac{1}{2}$, $\overline{I} = \frac{7}{2} / 2^{16}$

$$
\hat{H} = \beta \mathbf{H} \cdot \mathbf{g} \cdot \mathbf{S} + \mathbf{I} \cdot \mathbf{A} \cdot \mathbf{S} \tag{1}
$$

where the symbols have their usual meaning. Resolved hyperfine is seen only in Figure 4, which corresponds to the **Cs** molecular symmetry axis of cobaltocene being parallel to the applied magnetic field, H ¹⁷ Hence this spectrum is referred to as the parallel spectrum or the g_{zz} **spectrum.** Perpendicular to this orientation, Figure **5,** one can see that the other two g 's, g_{xx} and g_{yy} , are not quite can see that the other two g s, g_{xx} and g_{yy} , are not quite resolved. The hyperfine splitting, A_{xx} and A_{yy} , for this orientation is **also** not resolved. The lack of kyperfine resolution makes it difficult to determine a unique set of spin Hamiltonian parameters for eq 1. In the parallel spectrum, the spin Hamiltonian reduces to

$$
\hat{H} = g_{zz}\beta H M_S + A_{zz}\hat{S}_{zz}\hat{I}_{zz} + A_{yy}\hat{S}_{yy}\hat{I}_{yy} + A_{xx}\hat{S}_{xx}\hat{I}_{xx}
$$
 (2)

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where the first two terms are diagonal terms in the 16 **X** 16 **matrix** of the Hamiltonian. The last two terms conned states $(M_s \pm 1, M_I \pm 1 | M_S, M_I)$. The magnitude of (A_{xx}) $-A_{vv}$) affects the position of the resonant lines in the parallel orientation, but determining the individual A_{xx} and *Ayy* with any precision is not possible given the lack of resolved hyperfine structure in the perpendicular orientation. A summary of the spin Hamiltonian parameters is given in Table I. The spectra **are** consistent with neutral cobaltocene being present in the intercalated material. The *signal* is quite weak, however, and therefore one would expect the concentration of cobaltocene to be low. Our previous work using $Cd_2P_2S_6$ as the host lattice resulted in cobaltocene ESR spectra several orders of magnitude stronger than the present ones for an equivalent size sample. The dramatic **angular** dependence of the **spectrum** indicates that the cobaltocene molecules are at least partially ordered within the $SnSe_2-1%P$ host. The mosaic nature of our $SnSe₂-1%P$ crystals precludes a determination of the cobaltocene orientation with respect to the sulfur layers. The spectra were recorded at 5 ± 1 K. From the low-field microwave absorption (LFMA) we conclude that the sample was in the superconducting state while the data were collected.¹⁸ Above T_c , the cobaltocene spectra persisted, but at reduced strength. The sample has no ESR spectrum at room temperature.

Discussion

The presence of neutral cobaltocene in $SnSe_2 1\%P$ [CoCp₂]_{0.36} is consistent with the observation of a Co²⁺ **peak** in the *XPS* **spectrum.** Cobaltocenium, CoCp2+, where the cobalt is formally Co3+, is diamagnetic and hence **has** no ESR spectrum. The conclusion from the ESR experiments is that neutral cobaltocene is present in $SnSe₂ 1\%P{CoCp_{2}}_{0.36}$ but at a low concentration. While it was not possible to determine the orientation of the neutral cobaltocene with respect to the $SnSe_2-1\%P$, it can be stated that the cobaltocene is ordered within the $SnSe₂$ 1%P. The lack of hyperfine structure in Figure *5* in consistent with an arrangement such that the C_5 molecular **axis** of each cobaltocene is perpendicular to the applied magnetic field. Similarly, the lack of intensity in the region of g_{xx} or g_{yy} in Figure 4 in consistent with all the C_5 molecular axes being parallel to the applied magnetic field. It remains unclear whether the **spectrum in** Figure **4** is due entirely to cobaltocene. One could argue that the **spectrum** is a composite of a cobaltocene spectrum (providing the eight equally spaced lines) and a broad featyeless line at $g = 2$. If this is the case, then this second component also is very anisotropic since it is not observed in the perpendicular spectrum, Figure *5.*

From the low signal strength in the spectrum shown in Figures 4 and 5, one can conclude that the amount of neutral cobaltocene is low. This is consistent with the argument tbat the degree of charge transfer between cobaltocene and **a** host lattice will depend upon the electron affinity of the host lattice. It is complete for TaS₂, χ = 5.2 eV, and only partial for SnS_2 where $\chi = 4.2$ eV. The χ = 4.35 eV of SnSe₂ suggests that charge transfer should be greater than the **SnS2** *case* and leas than or equal to the $TaS₂$ case. The ESR results are consistent with this postulate. The X-ray photoelectron results are less straightforward.

X-ray photoelectron spectroscopy would appear to be the ideal spectroscopic method for determining the relative amounts of two different oxidation states of a metal in-

Figure 6. Ratio of $\text{Co}^{2+}/\text{Co}^{3+}$ as a function of X-ray exposure **time. Solid line ie a second-order kinetics fit** *wing* **eq 4; see text.**

corporated into a lattice. Despite being a surface technique with a sampling depth of only a few angstroms, one can cleave samples in situ and characterize "interior" surfaces which presumably represent the bulk. A more formidable problem is faced when the X-rays actually change the physical or chemical nature of the surface under study. In these cases, short exposure times are required to minim problem is faced when the X-rays actually change the physical or chemical nature of the surface under study. In these cases, short exposure times are required to minimized such effects.

As the data in Figure 1 clearly show, the Co $2p_{3/2}$ lineshape changes **as** a function of time. If we adopt the previous assignments for this line, namely, that the high binding energy (more negative) component is from $Co³$ and the low binding energy component is from $Co²⁺$, then after several hours of exposure time it appears that the Co2+/Co3+ ratio **is** 0.7. Combining this ratio with the known total cobalt content allows one to calculate the degree of charge transfer expressed **as**

$$
[Co^{3+}]/([Co^{2+}] + [Co^{3+}])
$$

The $Co²⁺/Co³⁺$ ratio of 0.7 implies that the degree of charge transfer between the cobaltocene and $SnSe_2-1%P$ is lower (60%) than between cobaltocene and SnS₂ (67%). This is contrary to what is expected based on the greater electronegativity of SnSe₂. At shorter exposure times, this Co2+/Co3+ ratio decreases. The critical question **is:** what is this ratio at zero exposure time? We have fit the four data points using a nonlinear least-squares fit to both a first- (3) and a second-order (4) kinetics equation:

$$
R(t) = R(\infty) - (R(\infty) - R(0))e^{-k_1t}
$$
 (3)

$$
R(t) = R(0) - \left(\frac{R(0)}{R(\infty)} - 1\right) \frac{k_2 t R(\infty)^2}{1 + k_2 t R(\infty)}
$$
(4)

where $R(\infty)$ is the ratio of Co^{2+}/Co^{3+} as $t \to \infty$, $R(0)$ the same ratio at $t = 0$, k_1 is the first-order rate constant, and k_2 is the second-order rate constant.¹⁹ The result of the first-order fit, assuming a 10% uncertainty in the measured Co^{2+}/Co^{3+} ratio, is $R(\infty) = 0.69 \pm 0.05$, $R(0) = 0.14 \pm 0.08$, and $k_1 = 0.034 \pm 0.017$ min⁻¹. The solid line in Figure 2 is the first-order fit using these parameters and eq 3. Such a fit still suggests a large Co^{2+}/Co^{3+} ratio at $t = 0$ which is inconsistent with the ESR results, although the large uncertainty may account for this difference. The result of the second-order fit is $R(\infty) = 0.78 \pm 0.10$, $R(0) = 0.00$ ± 0.27 , and $k_2 = 0.082 \pm 0.064$ min⁻¹. Figure 6 shows the second-order fit. This time the $\text{Co}^{2+}/\text{Co}^{3+}$ ratio at $t = 0$ *is* consistent with the **ESR** rgsults, but again the Uncertainty in *R(0)* is large. To decide which of the two fits is physically reasonsbie (or whether neither'is reasonable),

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one must know the processes which are occurring at the surface of the material while it is being irradiated. In either case (first- or second-order process), the Co^{2+}/Co^{3+} ratio extrapolated to $t = 0$ is consistent with $SnSe₂$ having a larger electronegativity with respect to $SnS₂$.

There are several possible explanations for a different Co2+/Co3+ ratio **as** measured by XPS and ESR. The first is that XPS probes only a few angstroms into the material making a comparison between XPS and ESR data difficult. (ESR typically samples the entire sample volume, see below.) For example, a low concentration of Co2+ **as** determined by ESR would appear as a high Co²⁺ concentration in XPS if the $Co²⁺$ preferentially reside at the surface of the material. Given that the samples were cleaved in the high-vacuum chamber of the XPS spectrometer to expose fresh interior surfaces, it is not clear that such a surface concentration phenomenon is relevant here. It is possible that the very act of cleaving the material perturbs Co^{2+}/Co^{3+} ratio.

A second explanation for the difference in the Co^{2+}/Co^{3+} ratio **as** determined by XPS and ESR concerns the penetration depth of microwaves into $SnSe_2-1$ % $P(CoCp_2)_{0.36}$. As already stated, $SnSe_2-1%P(CoCp_2)_{0.36}$ is metallic, and therefore there exists a plasma frequency, $\omega_{\rm p}$, such that for electromagnetic radiation $\omega < \omega_p$, the radiation decays exponentially in the material rather than propagates through it.²⁰ In Dyson's theory of conduction electron spin resonance (CESR), this effect is manifest through the skin depth, **6,** which is the region of the sample where the microwaves have enough amplitude to effect ESR transitions.2l It should be noted that a typical Dysonian **ESR** line shape **is** not observed for any of the temperatures or orientations used in this study. If in $SnSe_2-1%P(CoCp_2)_{0.36}$ the penetration depth is small, then only a fraction of the **total** sample volume is subjected to the microwave radiation. Therefore, a correspondingly small fraction of intercalated cobaltocene molecules would undergo ESR

transitions and the resultant ESR signal amplitude would not accurately reflect the concentration of paramagnetic molecules within the **total** sample.

A third possible reason for detecting a small amount of $Co²⁺$ using ESR is that none of the ESR samples were subjected to X-ray radiation. If most of the $Co²⁺$ observed in the *XPS* experiments is the result of radiation processes, then one would not expect similar concentrations to be observed in the nonradiated ESR samples.

Conclusions

We have investigated the time dependence of the Co $2p_{3/2}$ X-ray photoemission line from the intercalation product formed between SnSe₂-1% P and cobaltocene, $SnSe_2-1%P(CoCp_2)_{0.36}$, and have concluded that the line profile changes **as** a function of X-ray exposure time. This line shape suggests that the $SnSe_2-1\%P{CoCp_{2}}_{0.36}$ undergoes radiation damage and that care must be exercised when using XPS data to determine the relative amounts of Co^{3+} and Co^{2+} in this material. ESR data on $SnSe_2-1%P(CoCp_2)_{0.36}$ are consistent with the presence of a low concentration of neutral cobaltocene molecules in the intercalated product. The determination of the amount of Co^{2+} in $SnSe_2-1%P-$ (CoCP,],, *using XPS* depends on how the data is **analyzed;** a first-order fit suggests a significant concentration of Co^{2+} , and a second-order fit suggests a very low concentration of $Co²⁺$. ESR data are consistent with a very low $Co²⁺$ concentration. A detailed analysis of the magnetic **sus**ceptibility of this material might provide valuable insight into the relative amounts of $Co³⁺$ and $Co²⁺$ present in this compound.

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